



N- and P-Channel 100 V (D-S) MOSFET



| PRODUCT SUMMARY | | | | | | | |
|--|-----------|-----------|--|--|--|--|--|
| | N-CHANNEL | P-CHANNEL | | | | | |
| V _{DS} (V) | 100 | -100 | | | | | |
| $R_{DS(on)}(\Omega)$ at $V_{GS} = \pm 10 \text{ V}$ | 0.167 | 0.251 | | | | | |
| $R_{DS(on)}(\Omega)$ at $V_{GS} = \pm 4.5 \text{ V}$ | 0.186 | 0.338 | | | | | |
| Q _g typ. (nC) | 2.4 | 4.0 | | | | | |
| I _D (A) ^{a, b} | 4 | | | | | | |
| Configuration | N- and | p-pair | | | | | |

FEATURES

- TrenchFET® power MOSFETs
- Thermally enhanced PowerPAK®
- 100 % R_q tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

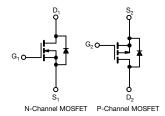


RoHSCOMPLIANT

HALOGEN FREE

APPLICATIONS

- DC/DC converters
- Active clamp
- · Brushless DC motors
- AC/DC inverter
- · Motor drive switch



| ORDERING INFORMATION | |
|---------------------------------|-----------------|
| Package | PowerPAK 1212-8 |
| Lead (Pb)-free and halogen-free | SIS590DN-T1-GE3 |

| ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted) | | | | | | |
|--|------------------------|-----------------|---------------------|---------------------|------|--|
| PARAMETER | | SYMBOL | N-CHANNEL | P-CHANNEL | UNIT | |
| Drain-source voltage | | V _{DS} | 100 | -100 | V | |
| Gate-source voltage | | V _{GS} | ± | V | | |
| | T _C = 25 °C | | 4 ⁹ | 4 9 | | |
| Continuous drain surrent | T _C = 70 °C | 1 . 🗆 | 4 ^g | 4 9 | ۸ | |
| Continuous drain current | T _A = 25 °C | I _D | 2.7 ^{a, b} | 2.3 ^{a, b} | A | |
| | T _A = 70 °C | 1 | 2.1 | 1.8 | | |
| Pulsed drain current (t = 100 μs) | | I _{DM} | 8 | 10 | | |
| Continuous source-drain diode current | T _C = 25 °C | | 14.9 | 19.3 | | |
| Continuous source-drain diode current | T _C = 70 °C | I _S | 9.5 | 12.3 | | |
| Single pulse avalanche current | L = 0.1 mH | I _{AS} | 4 | 10 | w | |
| Single pulse avalanche energy | L = 0.1 IIII | E _{AS} | 0.8 | 5.0 | VV | |
| | T _C = 25 °C | | 17.9 | 23.1 | | |
| Maximum Dawar Dissination | T _C = 70 °C | 1 , [| 11.4 | 14.8 | | |
| Maximum Power Dissipation | T _A = 25 °C | P _D | 2.5 ^{a, b} | 2.6 ^{a, b} | | |
| | T _A = 70 °C | 1 | 1.6 | 1.7 | | |
| Operating junction and storage temperature range T _J , T _{stg} -55 to +150 | | | | °C | | |
| Soldering recommendations (peak tempera | | 260 | | | | |

| THERMAL RESISTANCE RATINGS | | | | | | | |
|----------------------------------|--------------|------------|-------|-------|-------|-------|------|
| PARAMETER | | SYMBOL | N-CH/ | ANNEL | P-CH/ | ANNEL | UNIT |
| PANAMETEN | | STWIBOL | TYP. | MAX. | TYP. | MAX. | ONII |
| Maximum junction-to-ambient b, f | t ≤ 10 s | R_{thJA} | 40 | 50 | 38 | 48 | °C/W |
| Maximum junction-to-case (drain) | Steady state | R_{thJC} | 5.6 | 7 | 4.3 | 5.4 | C/VV |

- a. Based on silicon capability only
- b. Surface mounted on 1" x 1" FR4 board
- d. See solder profile (www.vishay.com/doc?73257). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
 e. Rework conditions: Manual soldering with a soldering iron is not recommended for leadless components
 f. Maximum under steady state conditions is 94 °C/W

- Package limited



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| PARAMETER | SYMBOL | TEST CONDITIONS | | MIN. | TYP. | MAX | UNIT | |
|---|-------------------------|--|------|------|-------|-------|-------|--|
| Static | | | | l | | | | |
| | | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | N-Ch | 100 | _ | _ | l | |
| Drain-source breakdown voltage | V _{DS} | $V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$ | P-Ch | -100 | - | - | V | |
| | | I _D = 250 μA | N-Ch | - | 79 | - | | |
| V _{DS} temperature coefficient | $\Delta V_{DS}/T_{J}$ | I _D = -250 μA | P-Ch | - | -68 | - | mV/°C | |
| | A)/ /T | I _D = 250 μA | N-Ch | - | -4.4 | - | | |
| V _{GS(th)} temperature coefficient | $\Delta V_{GS(th)}/T_J$ | I _D = -250 μA | P-Ch | - | 4.3 | - | | |
| Cata threshold valtage | V | $V_{DS} = V_{GS}, I_D = 250 \mu A$ | N-Ch | 1.5 | =. | 2.5 | V | |
| Gate threshold voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_{D} = -250 \mu A$ | P-Ch | -1.5 | - | -2.5 | V | |
| Gata bady laakaga | l | V 0 V V + 20 V | N-Ch | - | - | ± 100 | | |
| Gate-body leakage | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ | P-Ch | - | - | ± 100 | nA | |
| | | $V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}$ | N-Ch | - | - | 1 | | |
| Zero gate voltage drain current | 1 | $V_{DS} = -100 \text{ V}, V_{GS} = 0 \text{ V}$ | P-Ch | - | - | -1 | | |
| zero gate voltage drain current | I _{DSS} | V_{DS} = 100 V, V_{GS} = 0 V, T_J = 55 °C | N-Ch | - | - | 10 | μΑ | |
| | | V_{DS} = -100 V, V_{GS} = 0 V, T_J = 55 °C | P-Ch | - | - | -10 | | |
| On-state drain current ^b | 1 | $V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$ N-Ch | | 4 | - | - | ^ | |
| On-State drain current - | I _{D(on)} | $V_{DS} \le$ -5 V, $V_{GS} =$ -10 V | P-Ch | -4 | - | - | A | |
| Drain-source on-state resistance b | | $V_{GS} = 10 \text{ V}, I_D = 1.5 \text{ A}$ | N-Ch | - | 0.139 | 0.167 | - Ω | |
| | R _{DS(on)} | $V_{GS} = -10 \text{ V}, I_D = -2.3 \text{ A}$ | P-Ch | - | 0.197 | 0.251 | | |
| Drain-Source on-state resistance | | $V_{GS} = 4.5 \text{ V}, I_D = 1.0 \text{ A}$ | N-Ch | - | 0.155 | 0.186 | | |
| | | $V_{GS} = -4.5 \text{ V}, I_D = -2.0 \text{ A}$ | P-Ch | - | 0.260 | 0.338 | | |
| Forward transconductance b | a | $V_{DS} = 10 \text{ V}, I_D = 2.7 \text{ A}$ | N-Ch | - | 10 | - | - S | |
| Torward transcoriductance | 9fs | $V_{DS} = -10 \text{ V}, I_D = 2.3 \text{ A}$ | P-Ch | - | 24 | - | | |
| Dynamic ^a | | | _ | | | | | |
| Input capacitance | C _{iss} | | N-Ch | =. | 265 | - | pF | |
| mpat supusitanss | OISS | N-channel | P-Ch | - | 325 | - | | |
| Output capacitance | C _{oss} | $V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ | N-Ch | =. | 20 | - | | |
| Cutput capacitance | Ooss | P-channel | P-Ch | - | 90 | - | | |
| Reverse transfer capacitance | C _{rss} | $V_{DS} = -50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ | N-Ch | =. | 2 | = | | |
| rieverse transfer capacitance | Orss | | P-Ch | =. | 5 | - | | |
| | | $V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 0.2 \text{ A}$ | N-Ch | - | 5.2 | 104 | nC | |
| Total gate charge | Q_g | $V_{DS} = -50 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -9 \text{ A}$ | P-Ch | - | 11.2 | 22.4 | | |
| rotal gate charge | ₩g | | N-Ch | =. | 2.4 | 4.8 | | |
| | | N-channel | P-Ch | - | 5.7 | 11.4 | | |
| Gate-source charge | 0 | $V_{DS} = 50 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 0.2 \text{ A}$ | N-Ch | - | 1.0 | - | 110 | |
| Gate-source charge | Q _{gs} | P-channel | P-Ch | - | 2.4 | - | | |
| Gate drain charge | 0 | $V_{DS} = -50 \text{ V}, V_{GS} = -4.5 \text{ V}, I_D = 2.3 \text{ A}$ | N-Ch | - | 0.5 | - | | |
| Gate-drain charge | Q_{gd} | | | - | 2.5 | | | |
| Gate resistance | D | f = 1 MHz | | 0.24 | 1.2 | 2.4 | Ω | |
| Cate resistance | R_g | I = I IVITIZ | P-Ch | 0.76 | 3.8 | 7.6 | 5.2 | |

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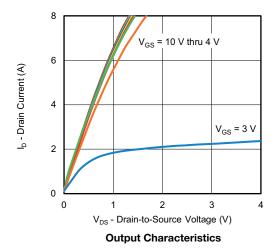
| PARAMETER | AMETER SYMBOL TEST CONDITIONS | | | | TYP. | MAX | UNIT |
|--|-------------------------------|--|------|---|-------|------|------|
| Dynamic ^a | | | | | | | |
| Turn-on delay time | t _{d(on)} | | N-Ch | - | 12 | 25 | |
| Tant on dolay time | ra(on) | N-channel | P-Ch | - | 15 | 30 | |
| Rise time | t _r | $V_{DD} = 10 \text{ V}, R_{L} = 2 \Omega$ | N-Ch | - | 45 | 90 | |
| T 100 til 110 | 4 | $I_D \cong 2.1 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$ | P-Ch | - | 50 | 100 | |
| Turn-off delay time | t _{d(off)} | P-channel | N-Ch | - | 22 | 45 | |
| Tam on dolay time | - a(oii) | V_{DD} = -10 V, R_L = 2 Ω $I_D \cong$ -1.8 A, V_{GEN} = -10 V, R_q = 1 Ω | P-Ch | - | 30 | 60 | |
| Fall time | t _f | g | N-Ch | - | 12 | 25 |] |
| | -1 | | P-Ch | - | 11 | 20 | ns |
| Turn-on delay time | t _{d(on)} | | N-Ch | - | 6 | 15 | 110 |
| Tam on dolay amo | -d(on) | N channel | P-Ch | - | 10 | 15 | |
| Rise time | t _r | N-channel $V_{DD} = 10 \text{ V}, R_L = 2 \Omega$ | N-Ch | - | 21 | 40 | |
| THISC LITTLE | ٠r | $I_D \cong 2.1 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$ | P-Ch | | 23 | 45 | |
| Turn-off delay time | t _{d(off)} | P-channel | N-Ch | - | 20 | 40 | |
| Turn-off delay time | | $V_{DD} = -10 \text{ V}, R_L = 2 \Omega$ $I_D \cong -1.8 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$ | P-Ch | - | 26 | 50 | |
| Fall time | t _f | J J GEN J g | N-Ch | | 10 | 20 | |
| Tall time | ч | | P-Ch | | 10 | 20 | |
| Drain-Source Body Diode Characteristi | cs | | | | , | T | T |
| Continuous source-drain diode current | I _S | T _A = 25 °C | N-Ch | - | - | 2.1 | - A |
| | | 1,7 20 0 | P-Ch | - | - | -2.2 | |
| Pulse diode forward current (t = 100 µs) | I _{SM} | | N-Ch | - | - | 8 | |
| | -3141 | | P-Ch | - | =. | -10 | |
| Body diode voltage | V _{SD} | I _S = 2.1 A, V _{GS} = 0 V | N-Ch | - | 0.8 | 1.2 | V |
| | - 3D | I _S = -1.8 A, V _{GS} = 0 V | P-Ch | - | -0.81 | -1.2 | v |
| Body diode reverse recovery time | t _{rr} | | N-Ch | - | 23 | 46 | ns |
| Body diode reverse recevery time | | | P-Ch | - | 37 | 74 | |
| Body diode reverse recovery charge | Q _{rr} | N-channel | N-Ch | - | 21 | 42 | nC |
| | ≪rr | $I_F = -1.8 \text{ A, dI//dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$ | P-Ch | - | 65 | 130 | |
| Reverse recovery fall time | t _a | P-channel | N-Ch | - | 21 | - | |
| neverse recovery rail time | ча | $I_F = -1.8 \text{ A}, \text{ dI/dt} = -100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$ | P-Ch | - | 34 | - | ns |
| Reverse recovery rise time | t _b | | | - | 2 | - | 113 |
| Reverse recovery rise time | 'D | | P-Ch | - | 3 | | |

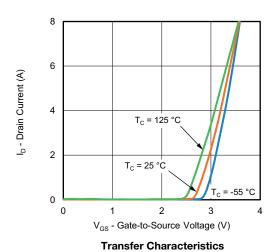
Notes

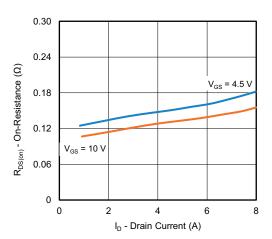
- a. Guaranteed by design, not subject to production testing.
- b. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

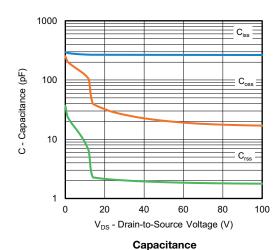
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



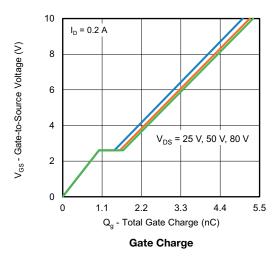


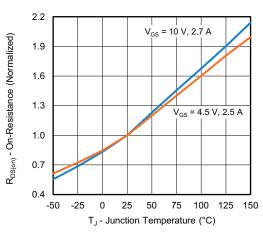






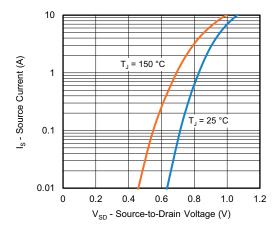
On-Resistance vs. Drain Current and Gate Voltage



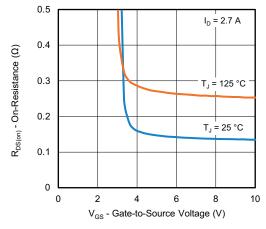


On-Resistance vs. Junction Temperature

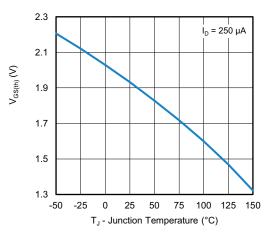




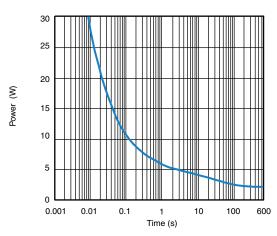
Source-Drain Diode Forward Voltage



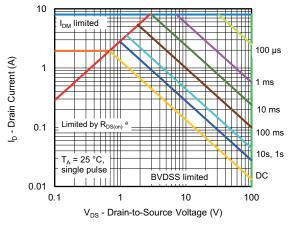
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power (Junction-to-Ambient)

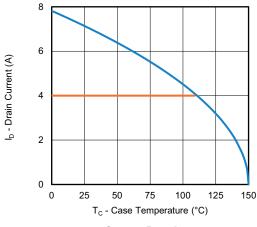


Safe Operating Area, Junction-to-Ambient

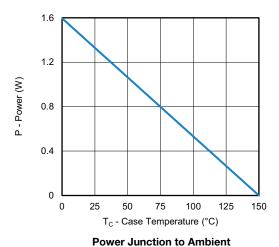
Note

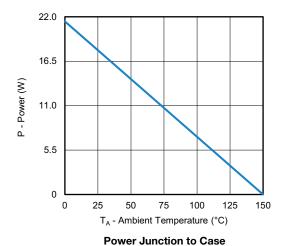
a. V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified







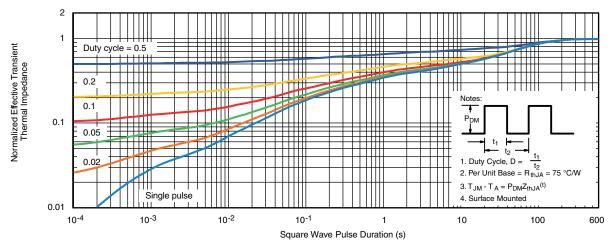




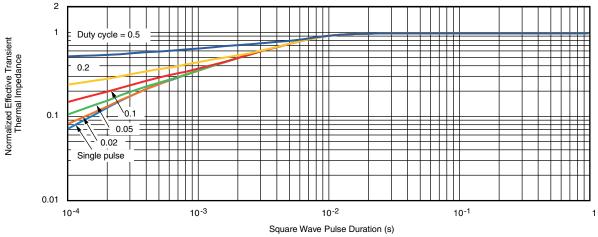
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



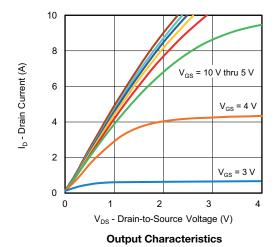


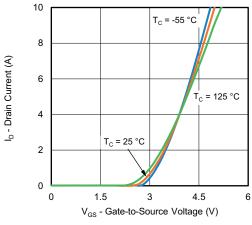
Normalized Thermal Transient Impedance, Junction-to-Ambient



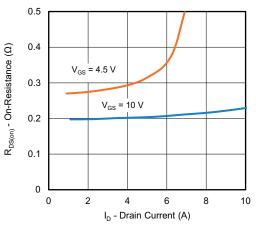
Normalized Thermal Transient Impedance, Junction-to-Case

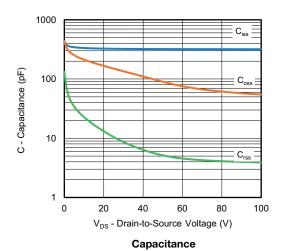




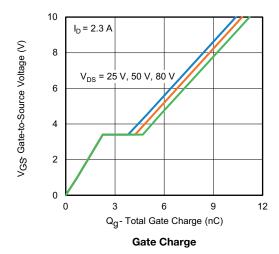


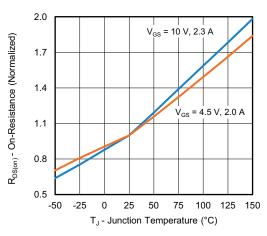






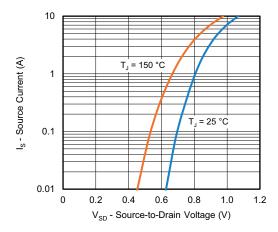
On-Resistance vs. Drain Current and Gate Voltage



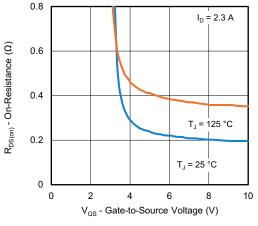


On-Resistance vs. Junction Temperature

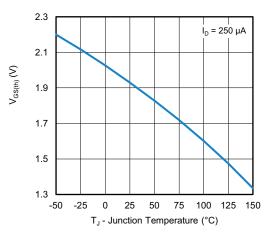




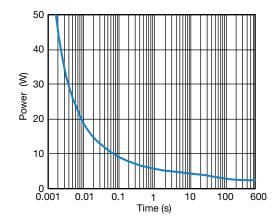
Source-Drain Diode Forward Voltage



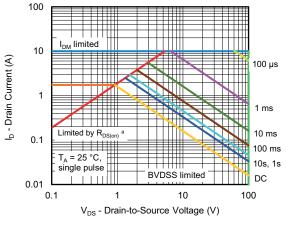
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power, Junction-to-Ambient

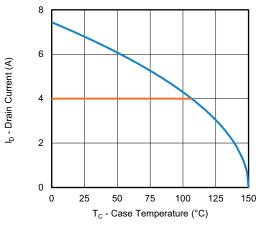


Safe Operating Area, Junction-to-Ambient

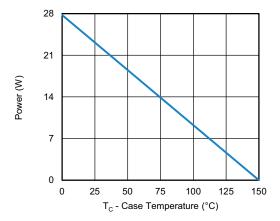
Note

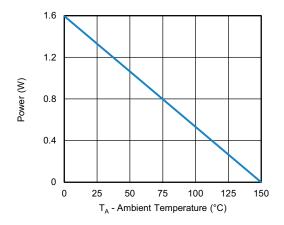
a. V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified





Current Derating a





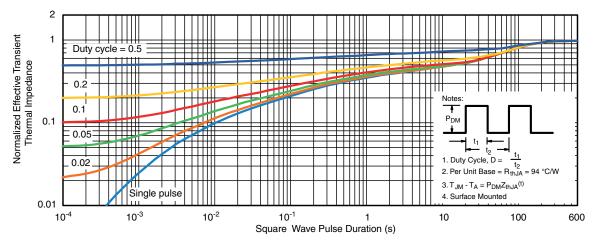
Power Junction to Ambient

Power Junction to Case

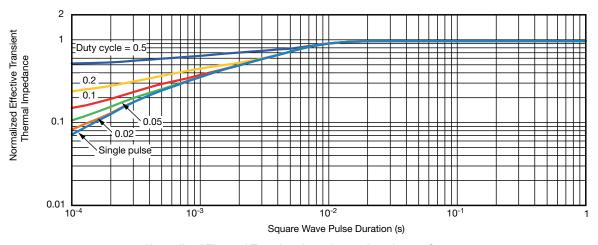
Note

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Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package / tape drawings, part marking, and reliability data, see www.vishay.com/ppg?63046.



PowerPAK® 1212-8, (Single / Dual)





Notes

- 1. Inch will govern
- 2 Dimensions exclusive of mold gate burrs 3. Dimensions exclusive of mold flash and cutting burrs



Backside view of dual pad

D2

추

| DIM. | | MILLIMETERS INCHES | | | | MILLIMETERS | | | |
|------|------------|--------------------|------|------------|------------|-------------|--|--|--|
| DIM. | MIN. | NOM. | MAX. | MIN. | NOM. | MAX. | | | |
| Α | 0.97 | 1.04 | 1.12 | 0.038 | 0.041 | 0.044 | | | |
| A1 | 0.00 | - | 0.05 | 0.000 | - | 0.002 | | | |
| b | 0.23 | 0.30 | 0.41 | 0.009 | 0.012 | 0.016 | | | |
| С | 0.23 | 0.28 | 0.33 | 0.009 | 0.011 | 0.013 | | | |
| D | 3.20 | 3.30 | 3.40 | 0.126 | 0.130 | 0.134 | | | |
| D1 | 2.95 | 3.05 | 3.15 | 0.116 | 0.120 | 0.124 | | | |
| D2 | 1.98 | 2.11 | 2.24 | 0.078 | 0.083 | 0.088 | | | |
| D3 | 0.48 | - | 0.89 | 0.019 | - | 0.035 | | | |
| D4 | | 0.47 typ. | | | 0.0185 typ | | | | |
| D5 | | 2.3 typ. | | | 0.090 typ | | | | |
| E | 3.20 | 3.30 | 3.40 | 0.126 | 0.130 | 0.134 | | | |
| E1 | 2.95 | 3.05 | 3.15 | 0.116 | 0.120 | 0.124 | | | |
| E2 | 1.47 | 1.60 | 1.73 | 0.058 | 0.063 | 0.068 | | | |
| E3 | 1.75 | 1.85 | 1.98 | 0.069 | 0.073 | 0.078 | | | |
| E4 | 0.034 typ. | | | 0.013 typ. | | | | | |
| е | 0.65 BSC | | | | 0.026 BSC | | | | |
| K | | 0.86 typ. | | | 0.034 typ. | | | | |
| K1 | 0.35 | - | - | 0.014 | - | = | | | |
| Н | 0.30 | 0.41 | 0.51 | 0.012 | 0.016 | 0.020 | | | |
| L | 0.30 | 0.43 | 0.56 | 0.012 | 0.017 | 0.022 | | | |
| L1 | 0.06 | 0.13 | 0.20 | 0.002 | 0.005 | 0.008 | | | |
| θ | 0° | - | 12° | 0° | - | 12° | | | |
| W | 0.15 | 0.25 | 0.36 | 0.006 | 0.010 | 0.014 | | | |
| М | | 0.125 typ. | • | 0.005 typ. | | | | | |

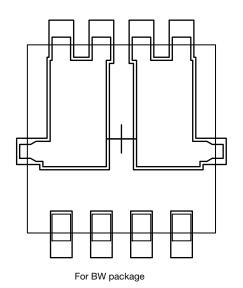
ECN: S16-2667-Rev. M, 09-Jan-17

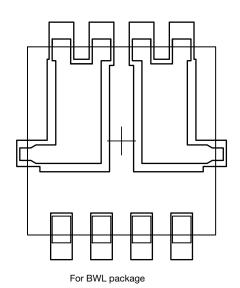
DWG: 5882 Revison: 09-Jan-17

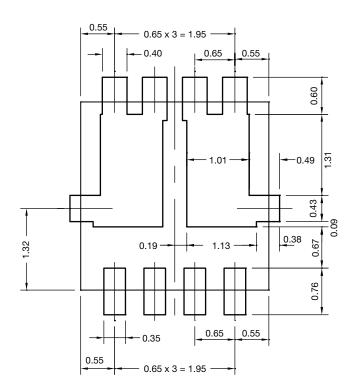
Document Number: 71656



Recommended Land Pattern for PowerPAK® 1212-8 Dual









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